SCDS008I - MAY 1993 - REVISED MAY 1998

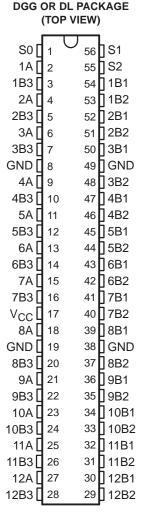
- 5- $\Omega$  Switch Connection Between Two Ports
- **TTL-Compatible Input Levels**
- **Package Options Include Plastic Thin** Shrink Small-Outline (DGG) and 300-mil Shrink Small-Outline (DL) Packages

### description

The SN74CBT16214 provides 12 bits of high-speed TTL-compatible bus switching between three separate ports. The low on-state resistance of the switch allows connections to be made with minimal propagation delay.

The device operates as a 12-bit bus-select switch via the data-select (S0-S2) terminals.

The SN74CBT16214 is characterized for operation from -40°C to 85°C.



#### **FUNCTION TABLE**

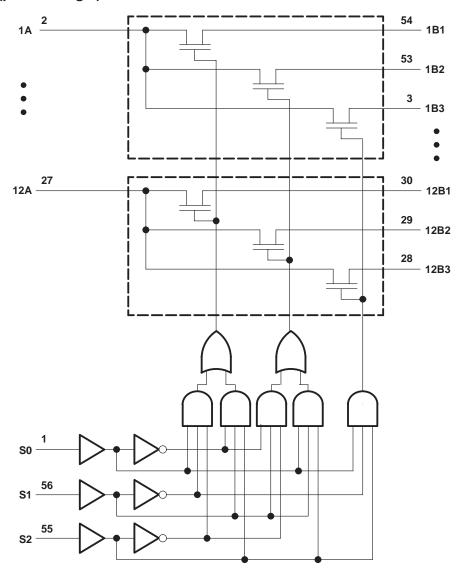
INPUTS			INPUT/OUTPUT	FUNCTION		
S2	S1	S0	Α	FUNCTION		
L	L	L	Z	Disconnect		
L	L	Н	B1	A port = B1 port		
L	Н	L	B2	A port = B2 port		
L	Н	Н	Z	Disconnect		
Н	L	L	Z	Disconnect		
Н	L	Н	В3	A port = B3 port		
Н	Н	L	B1	A port = B1 port		
Н	Н	Н	B2	A port = B2 port		



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## logic diagram (positive logic)



## absolute maximum ratings over operating free-air temperature range (unless otherwise noted)†

Supply voltage range, V <sub>CC</sub>	
Input voltage range, V <sub>I</sub> (see Note 1)	–0.5 V to 7 V
Continuous channel current	128 mA
Input clamp current, I <sub>IK</sub> (V <sub>I</sub> < 0)	–50 mA
Package thermal impedance, θ <sub>JA</sub> (see Note 2): DGG package	81°C
DL package	74°C
Storage temperature range, T <sub>stg</sub>	–65°C to 150°C

<sup>†</sup> Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

NOTES: 1. The input and output negative-voltage ratings may be exceeded if the input and output clamp-current ratings are observed.

2. The package thermal impedance is calculated in accordance with JESD 51.



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## recommended operating conditions (see Note 3)

		MIN	MAX	UNIT
VCC	Supply voltage	4	5.5	V
VIH	High-level control input voltage	2		V
V <sub>IL</sub>	Low-level control input voltage		0.8	V
TA	Operating free-air temperature	-40	85	°C

NOTE 3: All unused control inputs of the device must be held at V<sub>CC</sub> or GND to ensure proper device operation. Refer to the TI application report, Implications of Slow or Floating CMOS Inputs, literature number SCBA004.

## electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER		TEST CONDITIONS			MIN	TYP <sup>†</sup>	MAX	UNIT	
VIK		$V_{CC} = 4.5 \text{ V},$	$I_{I} = -18 \text{ mA}$				-1.2	V	
l <sub>1</sub>		$V_{CC} = 0$ ,	V <sub>I</sub> = 5.5 V				10	μΑ	
		$V_{CC} = 5.5 \text{ V},$	$V_I = 5.5 \text{ V or GND}$				±1		
Icc		$V_{CC} = 5.5 \text{ V},$	I <sub>O</sub> = 0,	$V_I = V_{CC}$ or GND			3	μΑ	
∆lcc <sup>‡</sup>	Control inputs	$V_{CC} = 5.5 \text{ V},$	One input at 3.4 V,	Other inputs at V <sub>CC</sub> or GND			2.5	mA	
Ci	Control inputs	V <sub>I</sub> = 3 V or 0				4		pF	
C <sub>io(OFF)</sub>		$V_0 = 3 \text{ V or } 0,$	A = Z			7.5		pF	
<sub>ron</sub> §		$V_{CC} = 4 \text{ V},$ TYP at $V_{CC} = 4 \text{ V}$	V <sub>I</sub> = 2.4 V,	I <sub>I</sub> = 15 mA					
			V <sub>I</sub> = 0	I <sub>I</sub> = 64 mA		4	7	Ω	
		$V_{CC} = 4.5 \text{ V}$	V   - 0	I <sub>I</sub> = 30 mA		4	7		
			V <sub>I</sub> = 2.4 V,	I <sub>I</sub> = 15 mA		6	12		

<sup>&</sup>lt;sup>†</sup> All typical values are at  $V_{CC} = 5 \text{ V}$  (unless otherwise noted),  $T_A = 25^{\circ}\text{C}$ .

# switching characteristics over recommended operating free-air temperature range, $C_L$ = 50 pF (unless otherwise noted) (see Figure 1)

PARAMETER	FROM (INPUT)	TO (OUTPUT)	V <sub>CC</sub> = 4 V	V <sub>CC</sub> = 5 V ± 0.5 V		UNIT
	(INFOT)	(0011 01)	MIN MAX	MIN	MAX	
$t_{pd}\P$	A or B	B or A	0.35		0.25	ns
t <sub>pd</sub>	S	B or A	15.3	5.5	13.9	ns
t <sub>en</sub>	S	A or B	16	5.1	14.5	ns
<sup>t</sup> dis	S	A or B	12.1	3.6	11.7	ns

The propagation delay is the calculated RC time constant of the typical on-state resistance of the switch and the specified load capacitance, when driven by an ideal voltage source (zero output impedance).

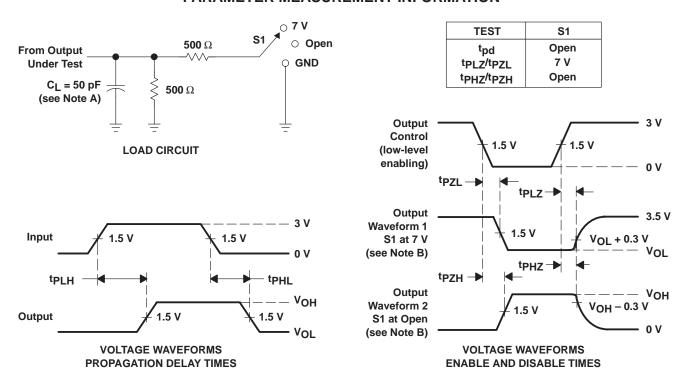


<sup>&</sup>lt;sup>‡</sup> This is the increase in supply current for each input that is at the specified TTL voltage level rather than V<sub>CC</sub> or GND.

<sup>§</sup> Measured by the voltage drop between the A and B terminals at the indicated current through the switch. On-state resistance is determined by the lower of the voltages of the two (A or B) terminals.

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### PARAMETER MEASUREMENT INFORMATION



NOTES: A. C<sub>I</sub> includes probe and jig capacitance.

- B. Waveform 1 is for an output with internal conditions such that the output is low except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high except when disabled by the output control.
- C. All input pulses are supplied by generators having the following characteristics: PRR  $\leq$  10 MHz,  $Z_O = 50 \Omega$ ,  $t_f \leq$  2.5 ns,  $t_f \leq$  2.5 ns.
- D. The outputs are measured one at a time with one transition per measurement.
- E. tpLz and tpHz are the same as tdis.
- F. tpzL and tpzH are the same as ten.
- G. tpLH and tpHL are the same as tpd.

Figure 1. Load Circuit and Voltage Waveforms



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